

<b>Notice of References Cited</b>	Application/Control No. 10/754,013		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner MICHAEL A. NEWMAN		Art Unit 2624	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,037,735	05-2006	Noguchi et al.	438/18
*	B	US-7,162,071	01-2007	Hung et al.	382/144
*	C	US-5,173,719	12-1992	Taniguchi et al.	356/394
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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#### FOREIGN PATENT DOCUMENTS

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	N					
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#### NON-PATENT DOCUMENTS

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